Se	arcn	NOI	es	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/707,286	DITLOW ET AL.	
Examiner	Art Unit	
Vuthe Siek	2825	

	SEAR	CHED	
Class	Subclass	Date	Examiner
716	7	7/28/2005	vs
		<del></del>	
		· 	

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARC		′)
	DATE	EXMR
EAST (ALL DATABASES) (See Search History Printout)	7/28/2005	vs